

TEST REPORT

Part 15 Subpart B&C 15.247

Equipment Under Test Galaxy Pen(Bluetooth)

Model Name IPBT-100-01, IPBT-100-02(Family model)

FCC ID ZGBIPBT-100-01

Applicant PENANDFREE Co., Ltd

Manufacturer PENANDFREE Co., Ltd

Date of test(s) 2011.08.05 ~ 2011.08.18

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Issued to

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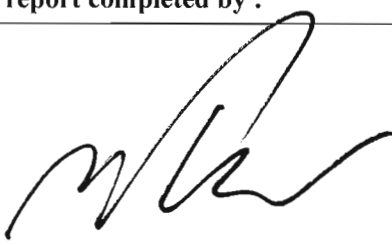
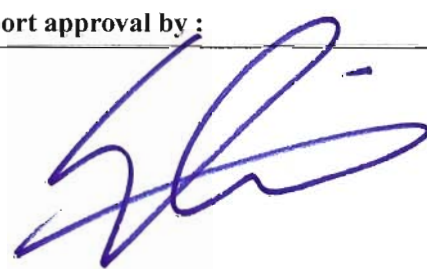
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Revision history

| Revision | Date of issue | Test report No. | Description |
|----------|---------------|-----------------|-------------|
| - | 2011.08.18 | TK-FR11049 | Initial |

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1.0 General product description

| | |
|--------------------------------|--|
| Equipment under test | Galaxy Pen(Bluetooth) |
| Model name | IPBT-100-01, IPBT-100-02(Family model) |
| Serial number | Prototype |
| Frequency Range | 2 402 MHz ~ 2 480 MHz |
| Modulation technique | GFSK |
| Number of channels | 79 |
| Antenna type & gain | Chip Antenna(3.1dBi) |
| Power source | 3V DC |

1.1 Test frequency

| | Low channel | Middle channel | High channel |
|------------------------|--------------------|-----------------------|---------------------|
| Frequency (MHz) | 2 402 | 2 441 | 2 480 |

1.2 Information about family model

Original model(IPBT-100-01) has family model(IPBT-100-02) according to the purpose and the technology of the product is fundamentally(Hardware & Software) the same.

1.3 Device modifications




N/A

1.4 Test facility

C3701 Dongil Techno Town, 889-1, Gwanyang 2-dong, Dongan-gu, Anyang-si, Gyeonggi-do, 431-716, Korea
477-6, Hageo-ri, Yeoju-eup, Yeoju-gun, Gyeonggi-do, 469-803, Korea

The sites are constructed in conformance with the requirements of ANSI C63.7, ANSI C63.4 and CISPR Publication 22.

1.5 Laboratory accreditations and listings

| Country | Agency | Scope of accreditation | Logo |
|---------|--------|--|--|
| USA | FCC | 3 & 10 meter Open Area Test Sites and one conducted site to perform FCC Part 15/18 measurements. |  343818 |
| KOREA | KCC | EMI (10 meter Open Area Test Site and two conducted sites) Radio (3 & 10 meter Open Area Test Sites and one conducted site) |  KR0100 |
| Canada | IC | 3 & 10 meter Open Area Test Sites and one conducted site |  4769B-1 |

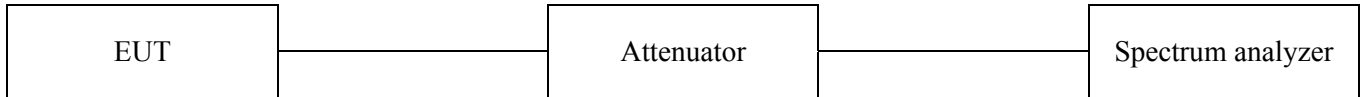
2.0 Summary of tests

| Section in FCC Part 15 | Parameter | Status |
|---|---|--------|
| 15.247(a)(1) | Frequency separation | C |
| 15.247(a)(1)(iii) | Number of hopping frequency | C |
| 15.247(a)(1) | 20 dB bandwidth | C |
| 15.247(a)(1)(iii) | Time of occupancy(Dwell time) | C |
| 15.247(b)(1) | Maximum peak output power | C |
| 15.247(d) | Conducted spurious emission & band edge | C |
| 15.247(d) | Radiated spurious emission & band edge | C |
| 15.207 | AC conducted emission | C |
| Note 1: C=Complies NC=Not complies NT=Not tested NA=Not applicable | | |

2.1 Technical characteristic test

2.1.1 Frequency separation

Test setup



Test procedure

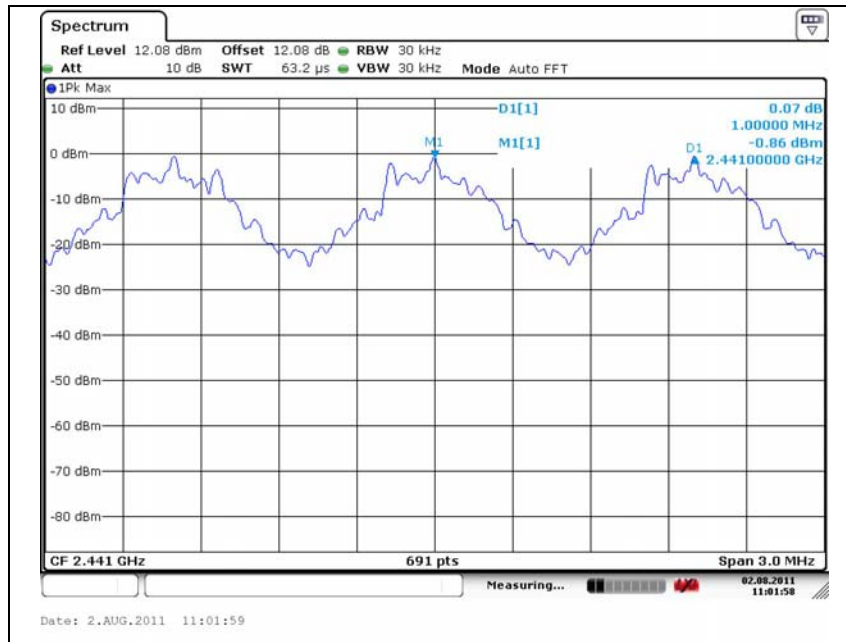
1. The EUT must have its hopping function enabled.
2. Use the following spectrum analyzer setting
 - Span = 3 MHz (wide enough to capture the peaks of two adjacent channels)
 - RBW = 30 kHz ($\geq 1\%$ of the span)
 - VBW = 30 kHz (\geq RBW)
 - Sweep = auto
 - Detector function = peak
 - Trace = max hold
3. All the trace to stabilize. Use the marker-delta function to determine the separation between the peaks of the adjacent channels.

Limit

15.247(a)(1) Frequency hopping system operating in 2 400 ~ 2 483.5 MHz. Band may have hopping channel carrier frequencies that are separated by 25 kHz or two-third of 20 dB bandwidth of the hopping channel, whichever is greater, provided the systems operate with an output power no greater than 125 mW.

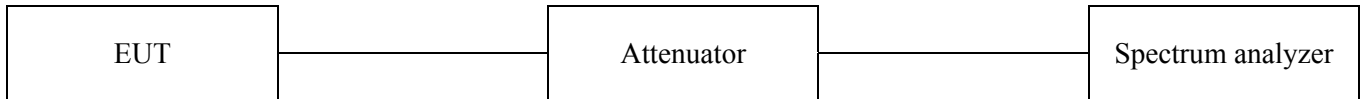
Test results

| Operation mode | Frequency (MHz) | Adjacent hopping channel separation (kHz) | Two-third of 20 dB bandwidth (kHz) | Minimum bandwidth (kHz) |
|----------------|-----------------|---|------------------------------------|-------------------------|
| GFSK | 2 441 | 1 000 | 555 | 25 |



2.1.2 Number of hopping frequency

Test setup



Test procedure

1. The EUT must have its hopping function enabled.
2. Use the following spectrum analyzer setting
 Frequency range: 2 400 MHz ~ 2 441.5 MHz, 2 441.5 MHz ~ 2 483.5 MHz
 Span = the frequency band of operation
 RBW = 300 kHz ($\geq 1\%$ of the span)
 VBW = 300 kHz (\geq RBW)
 Sweep = auto
 Detector function = peak
 Trace = max hold
3. All the trace to stabilize. Use the marker-delta function to determine the separation between the peaks of the adjacent channels.

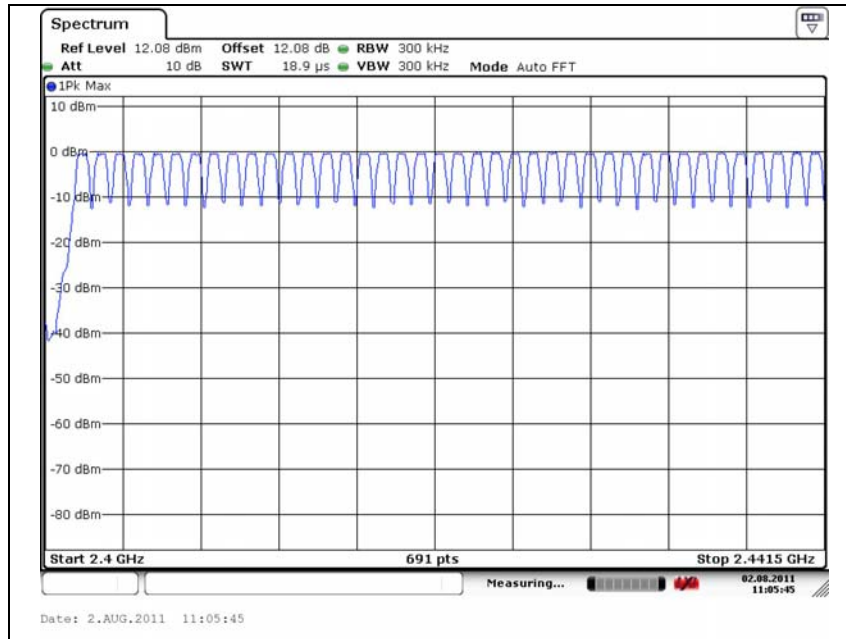
Limit

15.247(a)(1)(iii) For frequency hopping system operating in the 2 400 – 2 483.5 MHz bands shall use at least 15 hopping frequencies.

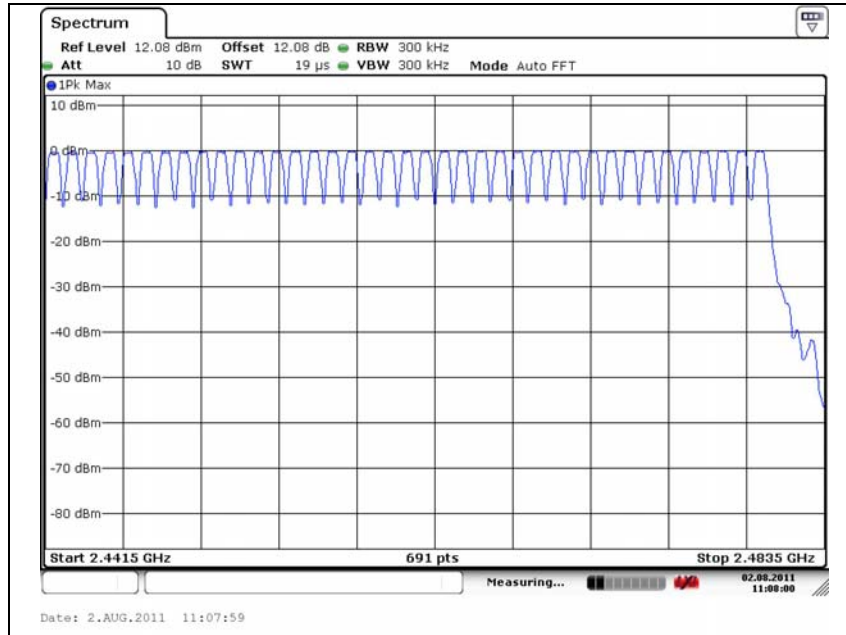
Test results

| Operation mode | Number of Hopping Frequency | Limit |
|----------------|-----------------------------|-----------|
| GFSK | 79 | ≥ 15 |

A. 2 400 MHz ~ 2 441.5 MHz

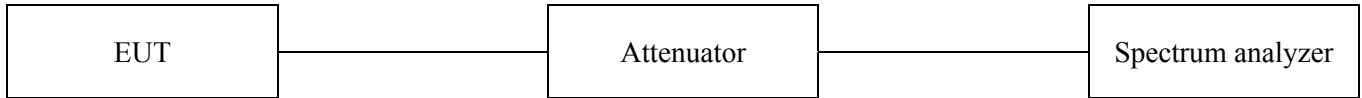


B. 2 441.5 MHz ~ 2 483.5 MHz



2.1.3 20 dB bandwidth

Test setup



Test procedure

1. Use the following spectrum analyzer setting
Center frequency: Lowest, middle and highest channels
Span = 3 MHz (Approximately 2 to 3 times the 20 dB bandwidth, centered on a hopping channel)
RBW = 30 kHz ($\geq 1\%$ of the span)
VBW = 30 kHz (\geq RBW)
Sweep = auto
Detector function = peak
Trace = max hold
2. The EUT should be transmitting at its maximum data rate. Allow the trace to stabilize.
Use the marker-to-peak function to set the marker to the peak of the emission. Use the marker-delta function to measure 20 dB down on side of the emission. Reset the marker-delta function, and move the marker to the other side of the emission, until it is (as close as possible to) even with the reference marker level.

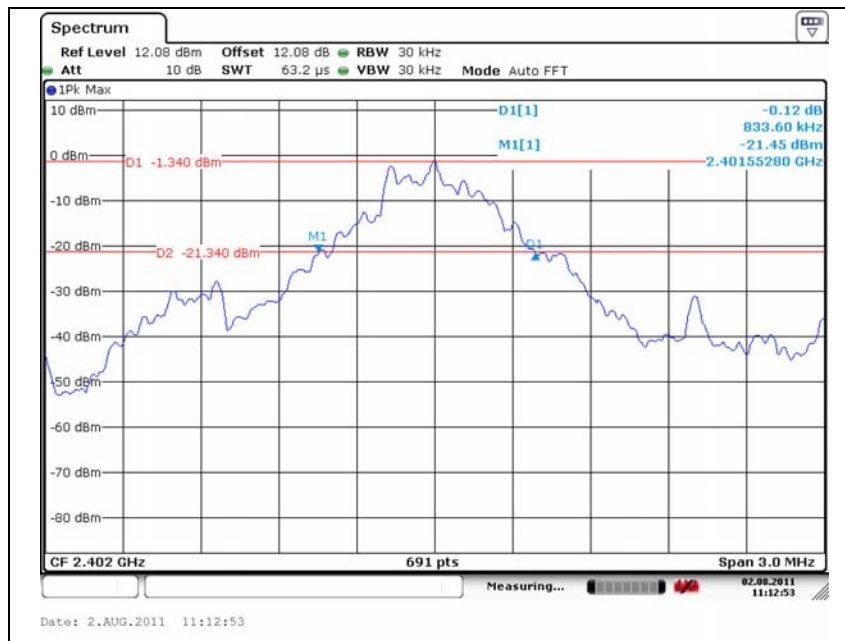
Limit

Not applicable

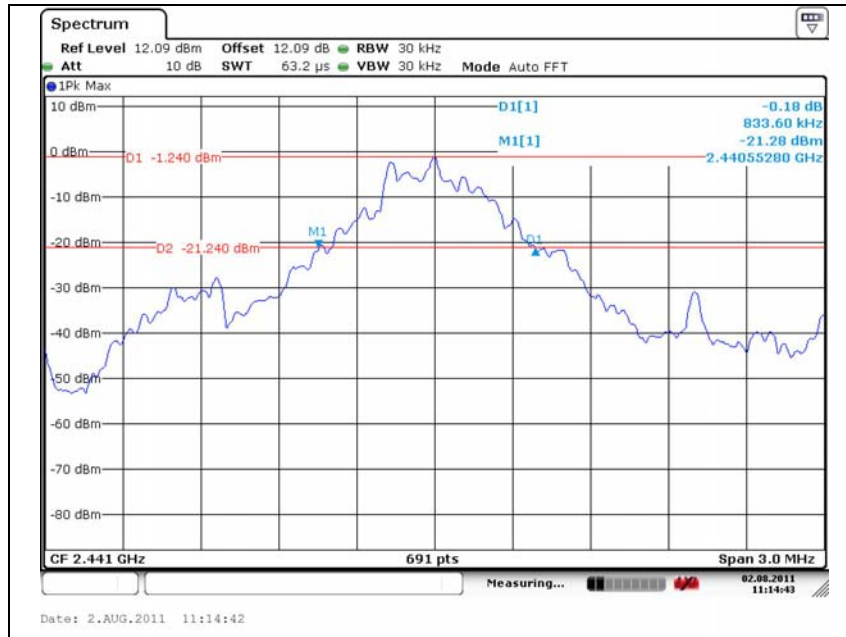
Test results

| Operation mode | Frequency(MHz) | 20 dB bandwidth(MHz) |
|----------------|----------------|----------------------|
| GFSK | 2 402 | 0.833 |
| | 2 441 | 0.833 |
| | 2 480 | 0.833 |

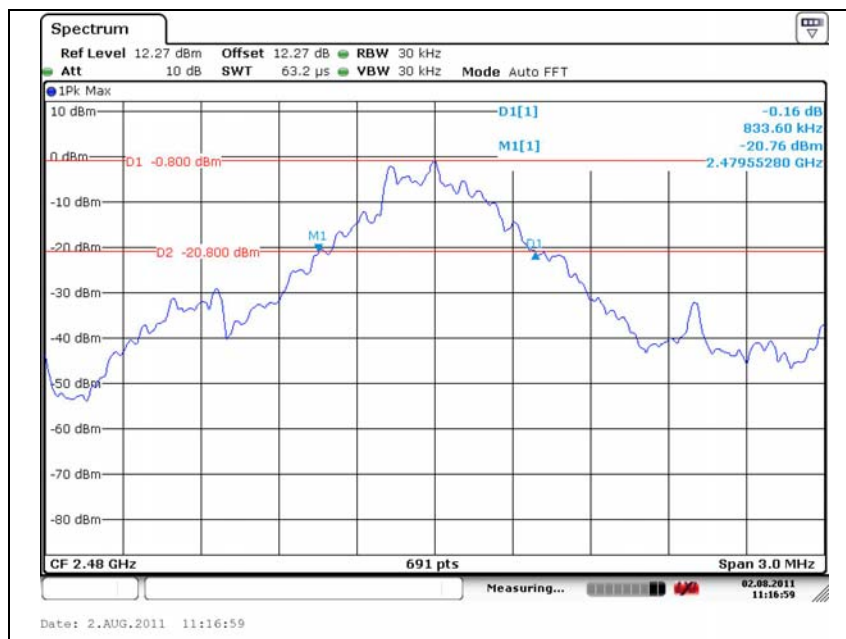
A. Low channel



B. Middle channel

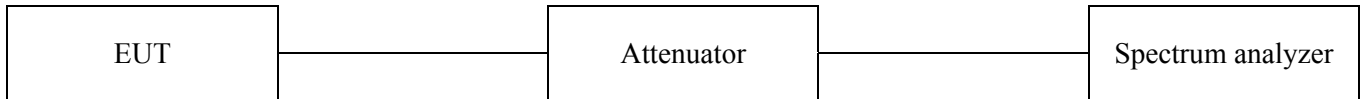


C. High channel



2.1.4 Time of occupancy (Dwell time)

Test setup



Test procedure

1. Use the following spectrum analyzer setting
Center frequency: 2 441 MHz
Span = Zero span, centered on a hopping channel
RBW = 1 MHz
VBW = 1 MHz (\geq RBW)
Sweep = as necessary to capture the entire dwell time per hopping channel
Detector function = peak
Trace = max hold
2. If possible, use the marker-delta function to determine the dwell time. If this value varies with different modes of operation (e.g., data rate, modulation format, etc.), repeat this test for each variation.
3. The Bluetooth has 3 type of payload DH1, DH3, DH5. The hopping rate is 1 600 per second.

Limit

15.247(a)(1)(iii) For frequency hopping system operating in the 2 400 ~ 2 483.5 MHz band, the average time of occupancy on any frequency shall not be greater than 0.4 second within a 31.6 second period.

A period time = $0.4(s) \times 79 = 31.6(s)$

Test results

Time of occupancy on the TX channel in 31.6 sec

= time domain slot length × (hop rate ÷ number of hop per channel) × 31.6

Operation mode: GFSK

| Packet type | Frequency (MHz) | Dwell Time (ms) | Time of occupancy on the Tx channel in 31.6 sec (ms) | Limit for time of occupancy on the Tx channel in 31.6 sec (ms) |
|-------------|-----------------|-----------------|--|--|
| DH1 | 2 441 | 0.398 | 127.36 | 400 |
| DH3 | 2 441 | 1.652 | 264.32 | 400 |
| DH5 | 2 441 | 2.898 | 309.12 | 400 |

※ Remark:

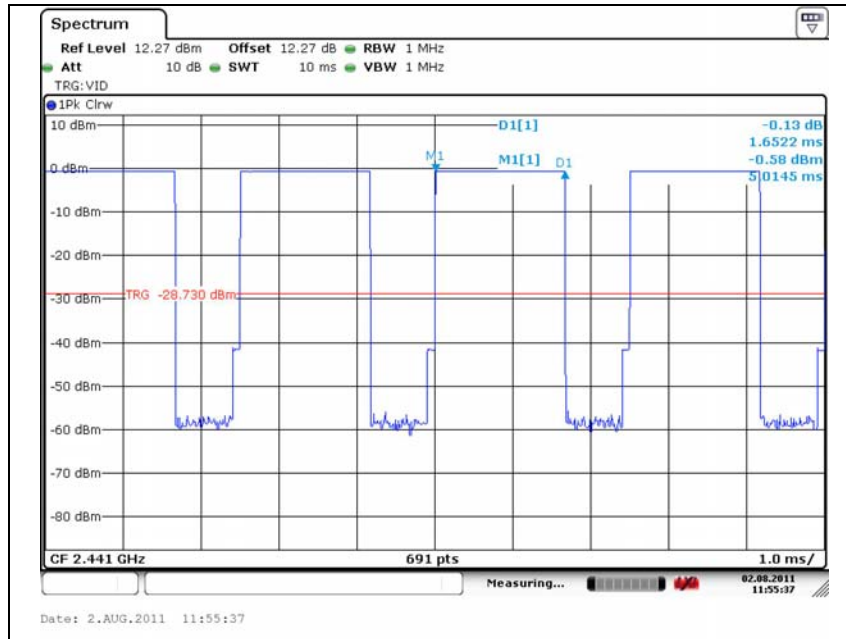
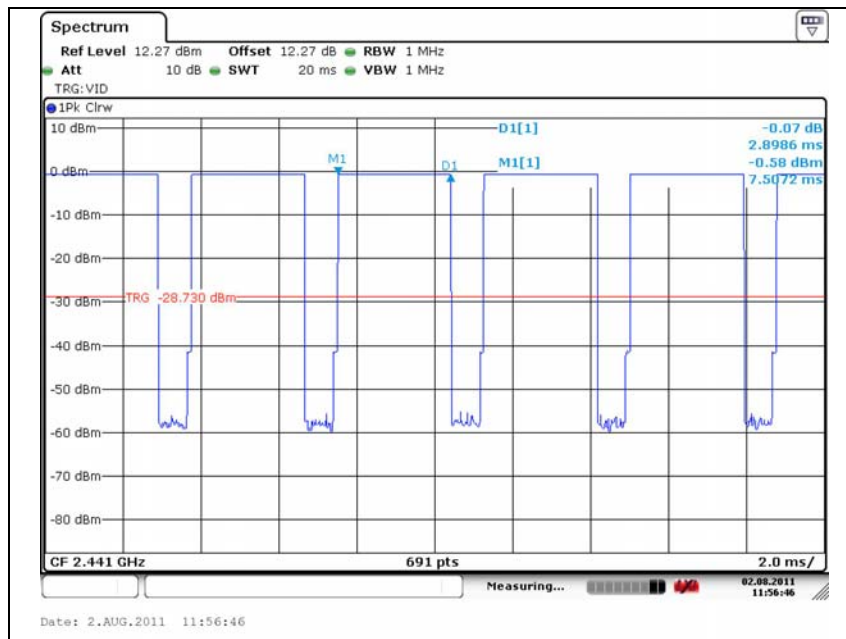
DH1: Dwell time (ms) × [(1 600 ÷ 2) ÷ 79] × 31.6(s) = Time of occupancy (ms)

DH3: Dwell time (ms) × [(1 600 ÷ 4) ÷ 79] × 31.6(s) = Time of occupancy (ms)

DH5: Dwell time (ms) × [(1 600 ÷ 6) ÷ 79] × 31.6(s) = Time of occupancy (ms)

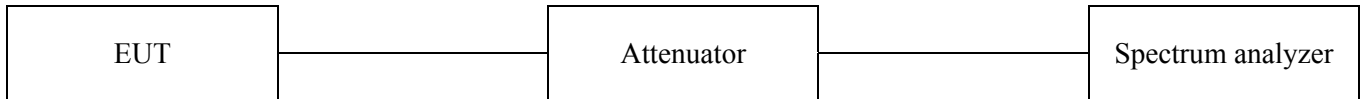
A. Packet type: DH1



B. Packet type: DH3**C. Packet type: DH5**

2.1.5 Maximum peak power output power

Test setup



Test procedure

1. Use the following spectrum analyzer setting
Center frequency: Lowest, middle and highest channels
Span = 5 MHz (Approximately 5 times the 20 dB bandwidth, centered on a hopping channel)
RBW = 1 MHz (the 20 dB bandwidth of the emission being measured)
VBW = 1 MHz (\geq RBW)
Sweep = auto
Detector function = peak
Trace = max hold
2. Allow the trace to stabilize. Use the marker-to-peak function to set the marker to the peak of the emission.
The indicated level is the peak output power.

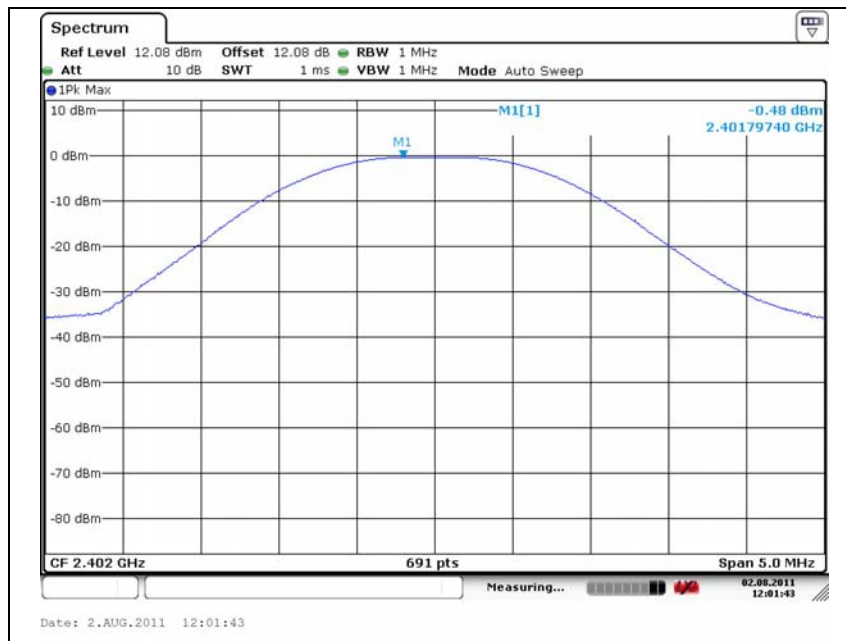
Limit

According to §15.247(b)(3), for systems using digital modulation in the 902 ~ 928 MHz, 2 400 ~ 2 483.5 MHz, and 5 725 ~ 5 850 MHz band: 1 Watt.

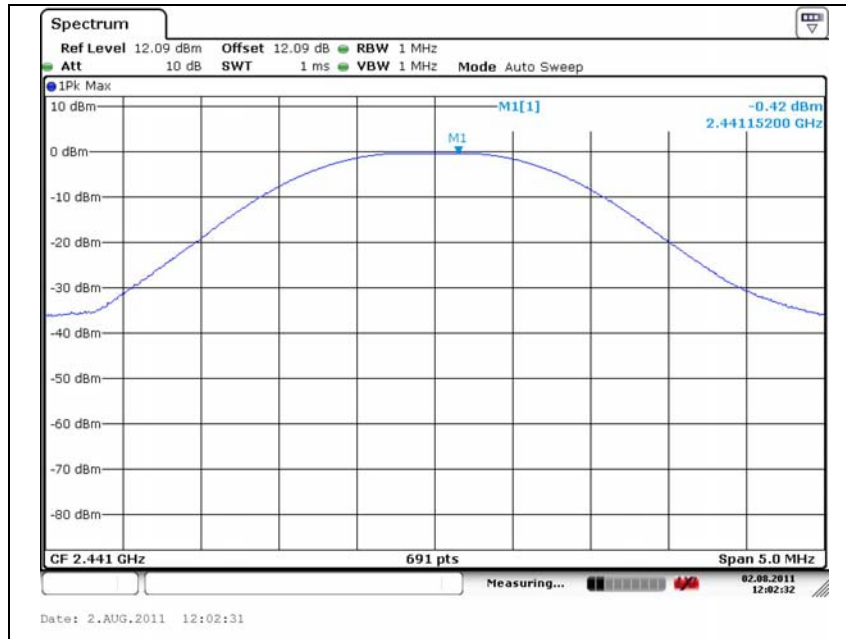
Test results

| Operation mode | Frequency(MHz) | Output power (dBm) | Limit (dBm) |
|----------------|----------------|--------------------|-------------|
| GFSK | 2 402 | -0.48 | 30 |
| | 2 441 | -0.42 | 30 |
| | 2 480 | -0.02 | 30 |

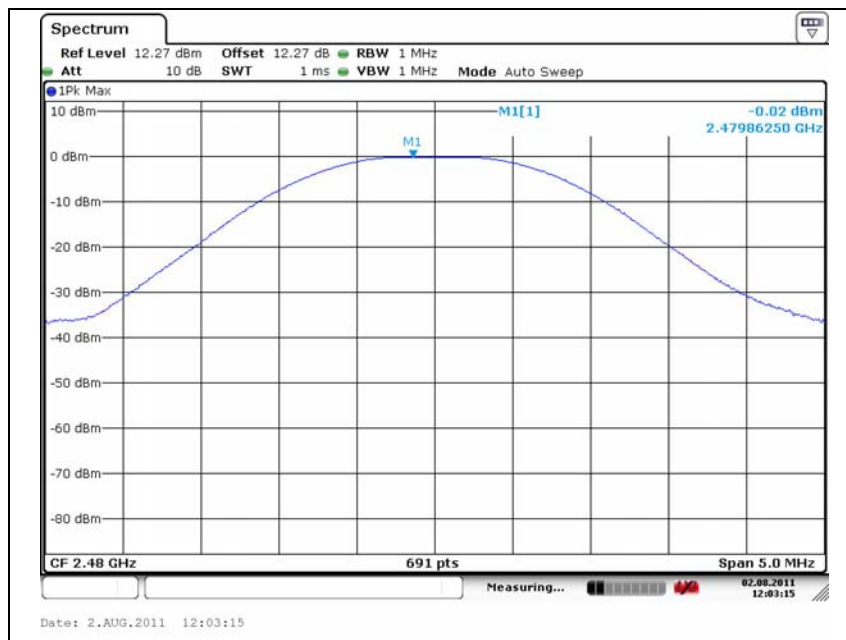
A. Low channel



B. Middle channel

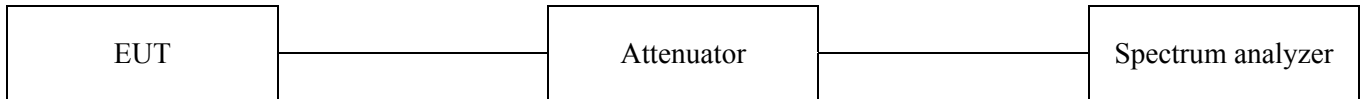


C. High channel



2.1.6 Conducted spurious emission & band edge

Test setup



Test procedure for band edge

1. Use the following spectrum analyzer setting
Center frequency: Lowest, middle and highest channels
Span = wide enough to capture the peak level of the emission operating on the channel closest to the band edge, as well as any modulation products which fall outside of the authorized band of operation.
RBW = 100 kHz
VBW = 100 kHz (\geq RBW)
Sweep = auto
Detector function = peak
Trace = max hold
2. Allow the trace to stabilize. Set the marker on the emission at the band edge, or on the highest modulation on product outside of the band, if this level is greater than that at the band edge.
Enable the marker-delta function, then use the marker-to-peak function to move the marker to the peak of the in-band emission

Test procedure for spurious emission

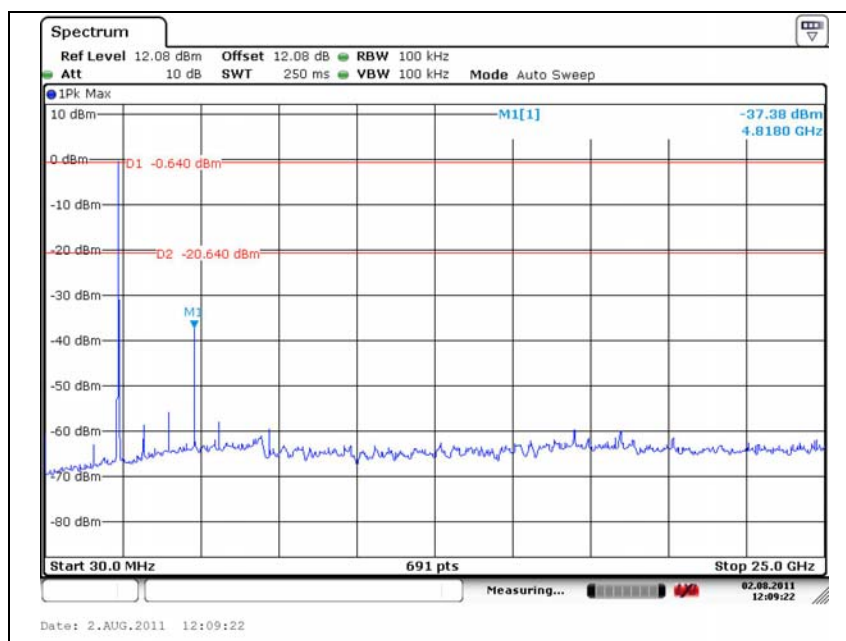
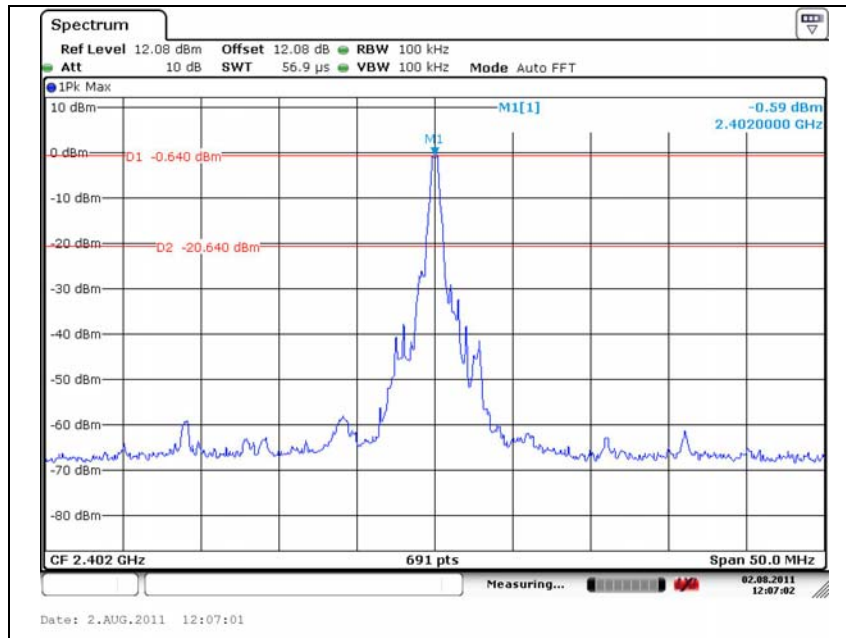
1. Use the following spectrum analyzer setting
Center frequency: Lowest, middle and highest channels
Span = wide enough to capture the peak level of the in-band emission and all spurious emissions(e.g. harmonics) from the lowest frequency generated in the EUT up through the 10th harmonics.
RBW = 100 kHz
VBW = 100 kHz (\geq RBW)
Sweep = auto
Detector function = peak
Trace = max hold
2. Allow the trace to stabilize. Set the marker on the peak of any spurious emission recorded.

Limit

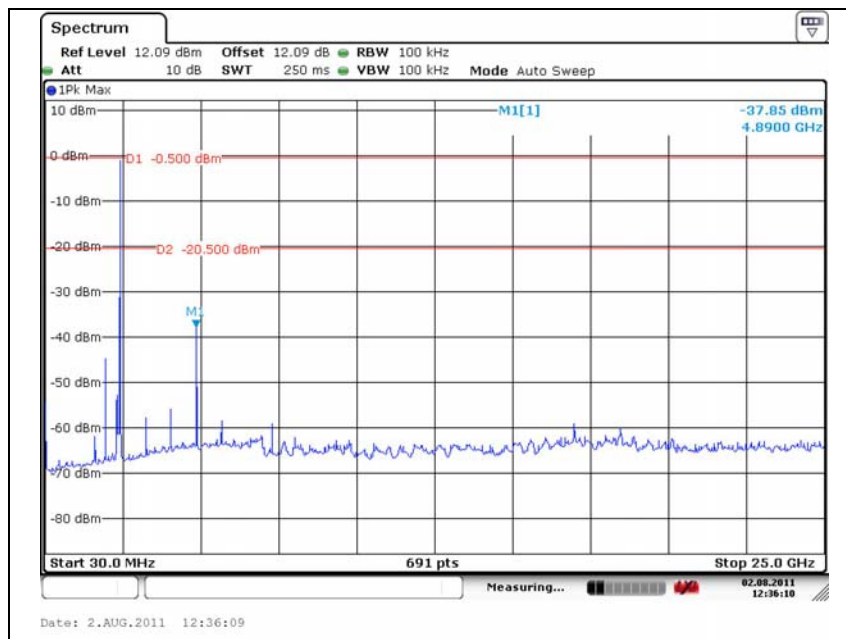
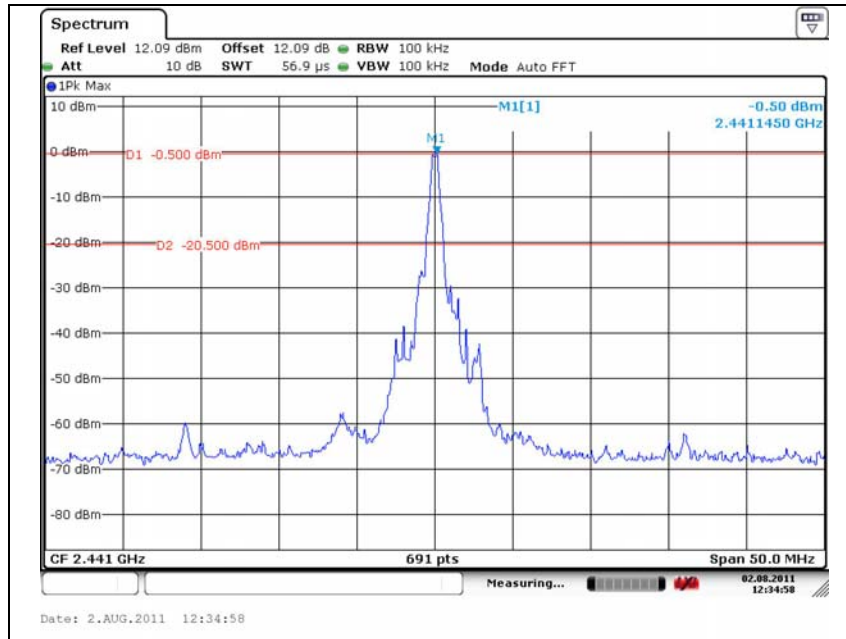
According to 15.247(d), in any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph(b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in section 15.209(a) is not required. In addition, radiated emission which in the restricted band, as defined in section 15.205(a), must also comply the radiated emission limits specified in section 15.209(a) (see section 15.205(c))

Test results

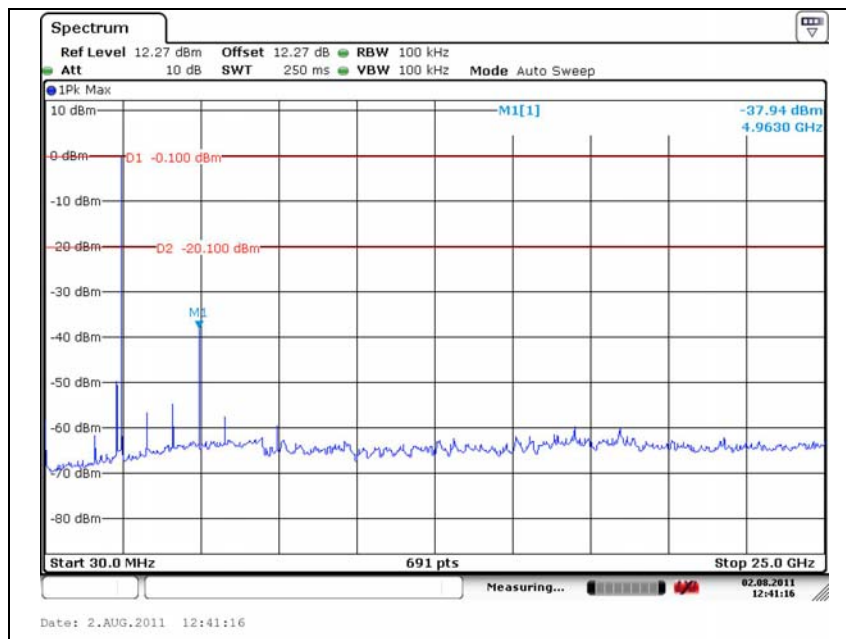
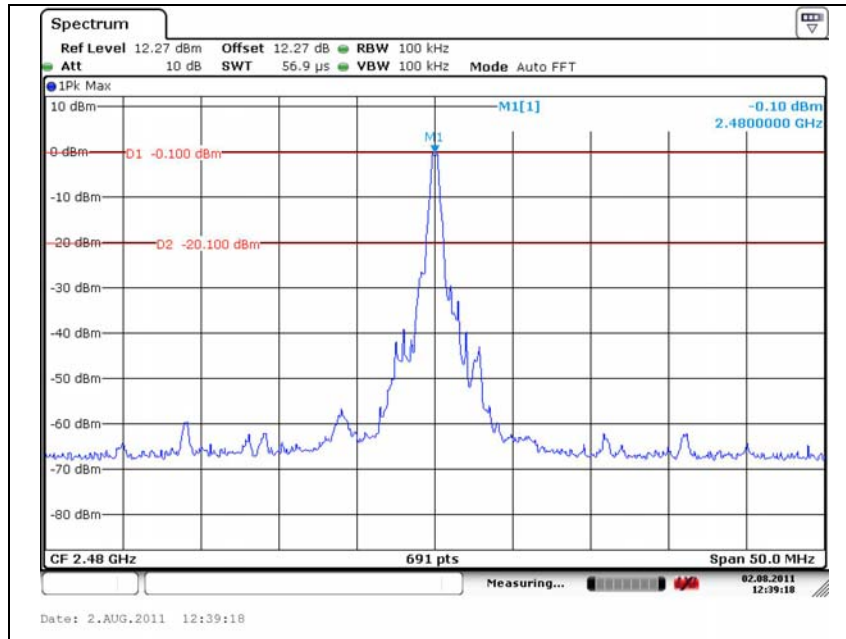
A. Low channel



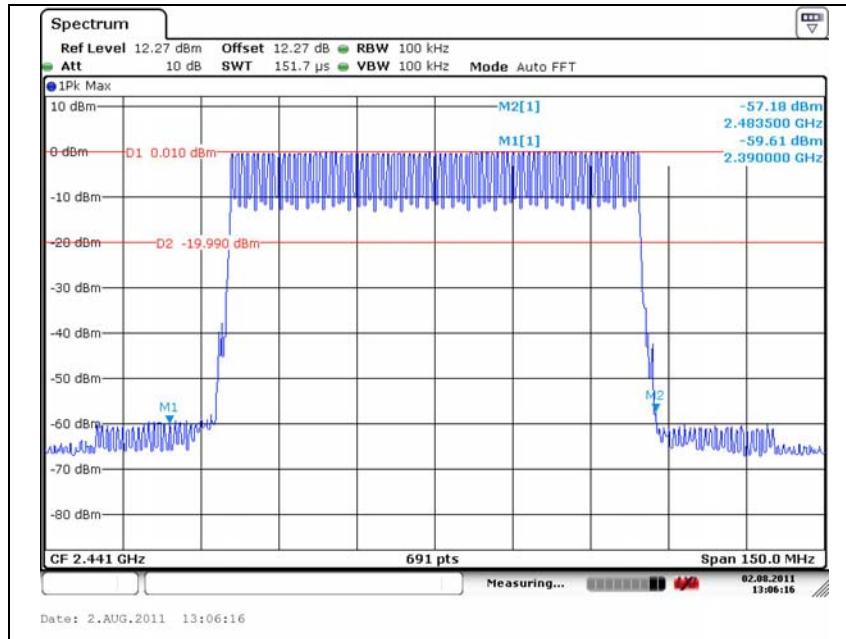
B. Middle channel



C. High channel



D. Band edge (Hopping mode)



2.1.7 Radiated spurious emission & band edge

Test location

Testing was performed at a test distance of 3 meter Open Area Test Site

Test procedures

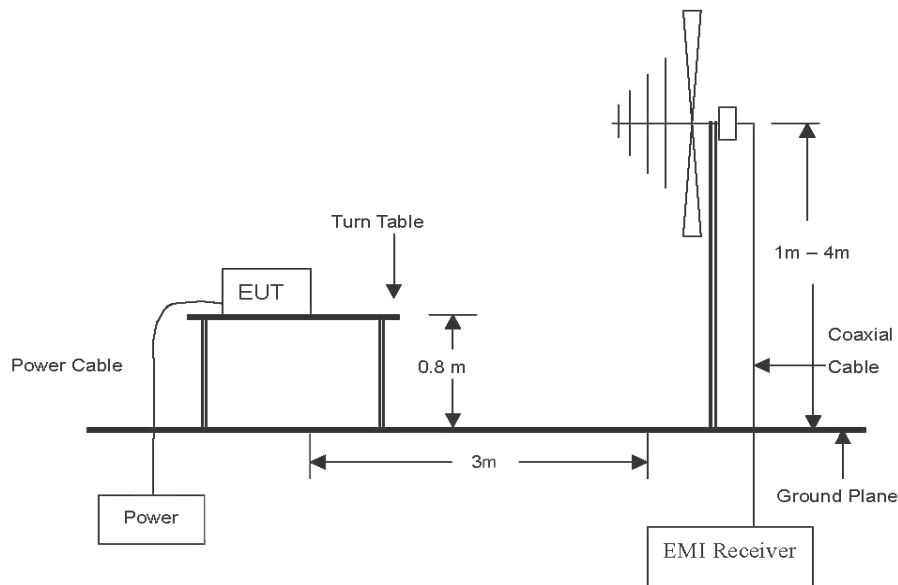
The height of the measuring antenna was varied between 1 to 4 m and the table was rotated a full revolution in order to obtain maximum values of the electric field intensity.

The measurement was made in both the vertical and horizontal polarization, and the maximum value is presented in the report.

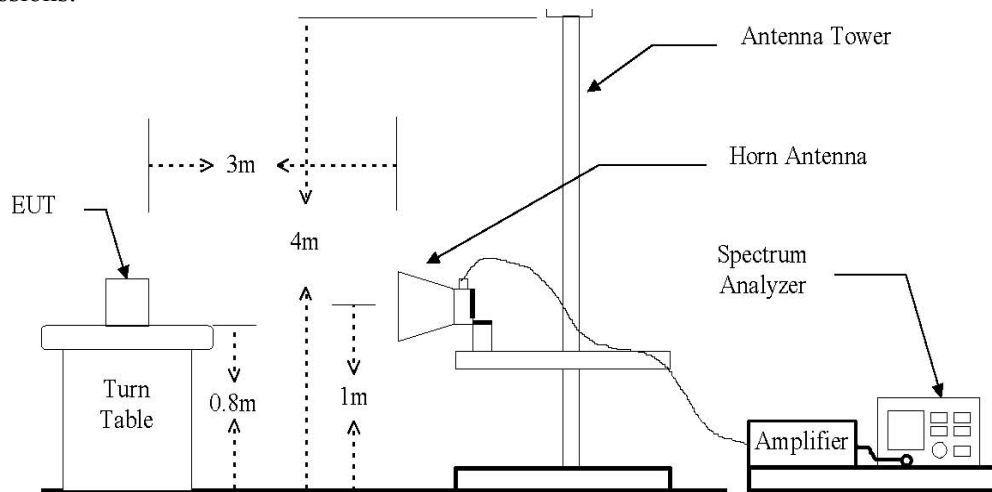
The spectrum analyzer is set to:

1. The resolution bandwidth and video bandwidth of test receiver/spectrum analyzer 120 kHz for Peak detection (PK) or Quasi-peak detection (QP) at frequency below 1 GHz.
2. The resolution bandwidth and video bandwidth of test receiver/spectrum analyzer is 1 MHz for Peak detection and frequency above 1 GHz.
3. The resolution bandwidth of test receiver/spectrum analyzer is 1 MHz and the video bandwidth is 10 Hz for Average detection (AV) at frequency above 1 GHz.

The diagram below shows the test setup that is utilized to make the measurements for emission from 30 MHz to 1 GHz emissions.



The diagram below shows the test setup that is utilized to make the measurements for emission from 1 GHz to 24 GHz emissions.



Limit

According to 15.209(a), for an intentional radiator devices, the general required of field strength of radiated emissions from unintentional radiators at a distance of 3 meters shall not exceed the following values :

| Frequency (MHz) | Distance (Meters) | Radiated (dB μ V/m) | Radiated (μ V/m) |
|-----------------|-------------------|-------------------------|-----------------------|
| 30 ~ 88 | 3 | 40.0 | 100 |
| 88 ~ 216 | 3 | 43.5 | 150 |
| 216 ~ 960 | 3 | 46.0 | 200 |
| Above 960 | 3 | 54.0 | 500 |

Test results (Below 1 000 MHz)

The frequency spectrum from 30 MHz to 1 000 MHz was investigated. Emission levels are not reported much lower than the limits by over 20 dB.

| Radiated emissions | | Ant. | Correction factors | | Total | Limit | |
|--------------------|-------------------------|------|-----------------------|---------------|--------------------------|-------------------------|----------------|
| Frequency (MHz) | Reading (dB μ V) | Pol. | Ant. factor (dB/m) | Cable (dB) | Actual (dB μ V/m) | Limit (dB μ V/m) | Margin (dB) |
| 176.0 | 9.01 | H | 13.62 | 2.50 | 25.13 | 43.5 | 18.37 |
| 196.5 | 10.77 | H | 11.18 | 2.67 | 24.62 | 43.5 | 18.88 |
| 326.3 | 9.42 | H | 14.33 | 3.56 | 27.31 | 46 | 18.69 |
| 436.0 | 8.07 | V | 16.60 | 4.22 | 28.89 | 46 | 17.11 |

※ Remark

1. All spurious emission at channels are almost the same below 1 GHz, so that middle channel was chosen at representative in final test.
2. Actual = Reading + Ant. factor + Amp + CL (Cable loss)
3. Detector mode: Quasi peak
4. To get a maximum emission level from the EUT, the EUT was moved throughout the XY, XZ and YZ planes.

Test results (Above 1 000 MHz)**A. Low channel**

| Radiated emissions | | | Ant. | Correction factors | | Total | Limit | |
|--------------------|----------------------|---------------|------|--------------------|---------------|-----------------------|----------------------|-------------|
| Frequency (MHz) | Reading (dB μ V) | Detector mode | Pol. | Ant. factor (dB/m) | Amp + CL (dB) | Actual (dB μ V/m) | Limit (dB μ V/m) | Margin (dB) |
| 2 390 | 50.49 | Peak | H | 28.31 | -38.02 | 40.78 | 74.00 | 33.22 |
| 2 390 | 51.04 | Peak | V | 28.31 | -38.02 | 41.33 | 74.00 | 32.67 |
| 4 804 | 55.81 | Peak | V | 33.91 | -34.11 | 55.61 | 74.00 | 18.39 |
| 4 804 | 44.13 | Average | V | 33.91 | -34.11 | 43.93 | 54.00 | 10.07 |
| 4 804 | 58.17 | Peak | H | 33.91 | -34.11 | 57.97 | 74.00 | 16.03 |
| 4 804 | 43.58 | Average | H | 33.91 | -34.11 | 43.38 | 54.00 | 10.62 |

B. Middle channel

| Radiated emissions | | | Ant. | Correction factors | | Total | Limit | |
|--------------------|----------------------|---------------|------|--------------------|---------------|-----------------------|----------------------|-------------|
| Frequency (MHz) | Reading (dB μ V) | Detector mode | Pol. | Ant. factor (dB/m) | Amp + CL (dB) | Actual (dB μ V/m) | Limit (dB μ V/m) | Margin (dB) |
| 4 882 | 59.25 | Peak | H | 34.16 | -33.92 | 59.49 | 74.00 | 14.51 |
| 4 882 | 45.81 | Average | H | 34.16 | -33.92 | 46.05 | 54.00 | 7.95 |
| 4 882 | 59.23 | Peak | V | 34.16 | -33.92 | 59.47 | 74.00 | 14.53 |
| 4 882 | 46.01 | Average | V | 34.16 | -33.92 | 46.25 | 54.00 | 7.75 |

C. High channel

| Radiated emissions | | | Ant. | Correction factors | | Total | Limit | |
|--------------------|----------------------|---------------|------|--------------------|---------------|-----------------------|----------------------|-------------|
| Frequency (MHz) | Reading (dB μ V) | Detector mode | Pol. | Ant. factor (dB/m) | Amp + CL (dB) | Actual (dB μ V/m) | Limit (dB μ V/m) | Margin (dB) |
| 2 483.5 | 50.11 | Peak | H | 28.50 | -37.81 | 40.80 | 74.00 | 33.20 |
| 2 483.5 | 50.22 | Peak | V | 28.50 | -37.81 | 40.91 | 74.00 | 33.09 |
| 4 960 | 57.17 | Peak | V | 34.42 | -33.73 | 57.86 | 74.00 | 16.14 |
| 4 960 | 45.10 | Average | V | 34.42 | -33.73 | 45.79 | 54.00 | 8.21 |
| 4 960 | 57.43 | Peak | H | 34.42 | -33.73 | 58.12 | 74.00 | 15.88 |
| 4 960 | 45.17 | Average | H | 34.42 | -33.73 | 45.86 | 54.00 | 8.14 |

※ Remark

1. “*” means the restricted band.
2. Measuring frequencies from 1 GHz to the 10th harmonic of highest fundamental frequency.
3. Radiated emissions measured in frequency above 1 000 MHz were made with an instrument using peak/average detector mode.
4. Average test would be performed if the peak result were greater than the average limit.
5. Actual = Reading + Ant. factor + Amp + CL (Cable loss)
6. To get a maximum emission level from the EUT, the EUT was moved throughout the XY, XZ and YZ planes.

2.1.8 AC conducted emissions

Frequency range of measurement

150 kHz to 30 MHz

Instrument settings

IF Band Width: 9 kHz

Test procedures

The EUT was placed on a non-metallic table 0.8m above the metallic, grounded floor and 0.4m from the reference ground plane wall. The distance to other metallic surfaces was at least 0.8m. Amplitude measurements were performed with a quasi-peak detector and an average detector.

Limit

15.207(a) for an intentional radiator that is designed to be connected to the public utility (AC) power line, the radio frequency voltage that is conducted back onto the AC power line on any frequency or frequencies, within the band 150 kHz to 30 MHz, shall not exceed the limits in the following table, as measured using a 50uH/50 ohm line impedance stabilization network (LISN). Compliance with the provision of this paragraph shall on the measurement of the radio frequency voltage between each power line and ground at the power terminal. The lower applies at the boundary between the frequencies ranges.

| Frequency of Emission (MHz) | Conducted limit (dBuV/m) | |
|-----------------------------|--------------------------|----------|
| | Quasi-peak | Average |
| 0.15 – 0.50 | 66 - 56* | 56 - 46* |
| 0.50 – 5.00 | 56 | 46 |
| 5.00 – 30.0 | 60 | 50 |

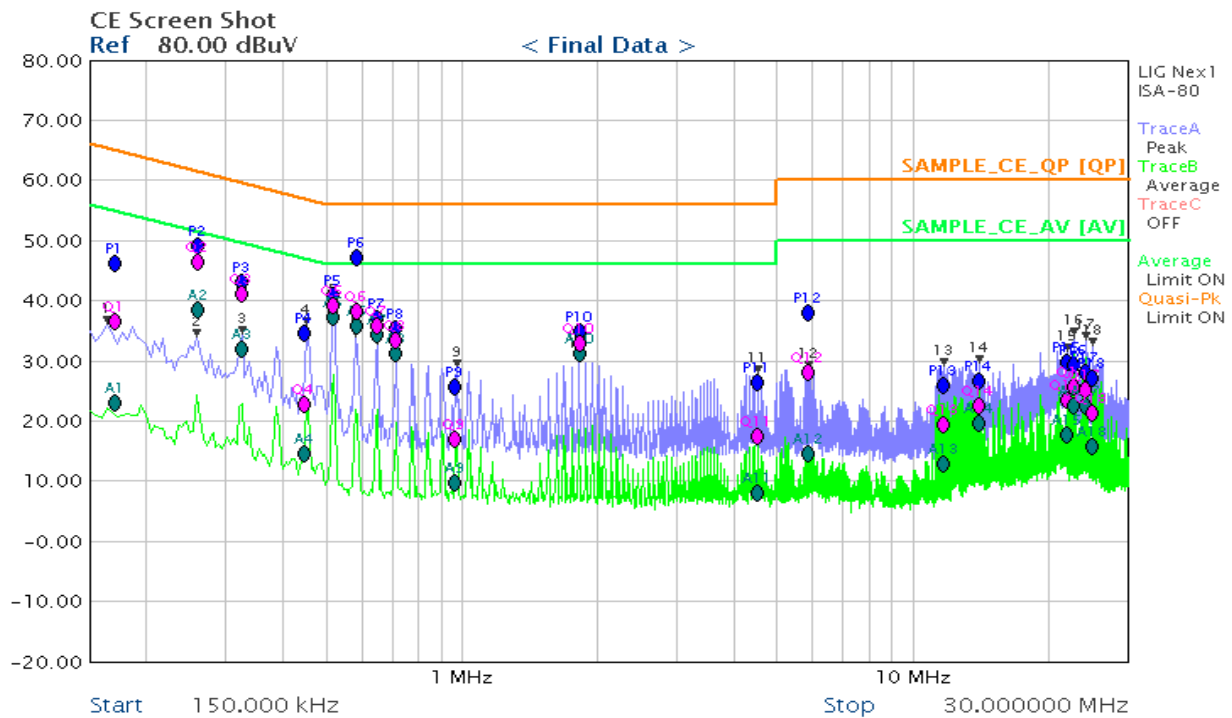
※ Remark

Decreases with the logarithm of the frequency.

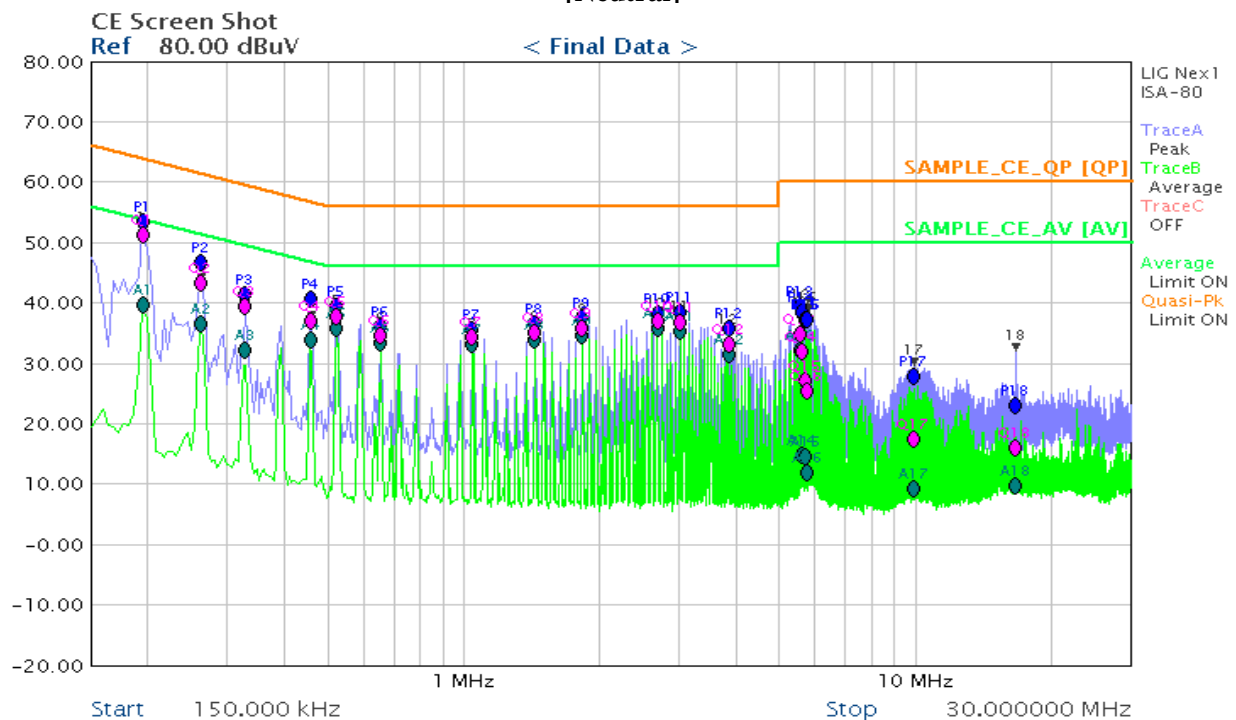
Test results

| Frequency (MHz) | Correction | | Phase Hot/ Neutral | Quasi peak | | | Average | | |
|--------------------|------------|---------------|--------------------------|------------|--------|-----------|---------|--------|-----------|
| | LISN | Cable Loss | | Reading | Result | Limit | Reading | Result | Limit |
| 0.196 | 9.772 | 0.104 | N | 41.354 | 51.230 | 64 | 29.684 | 39.560 | 54 |
| 0.261 | 9.764 | 0.100 | H | 36.516 | 46.380 | 61 | 28.446 | 38.310 | 51 |
| 0.262 | 9.764 | 0.100 | N | 33.366 | 43.230 | 61 | 26.426 | 36.290 | 51 |
| 0.327 | 9.760 | 0.100 | H | 31.140 | 41.000 | 60 | 22.050 | 31.910 | 50 |
| 0.328 | 9.757 | 0.100 | N | 29.553 | 39.410 | 60 | 22.123 | 31.980 | 50 |
| 0.459 | 9.750 | 0.100 | N | 26.940 | 36.790 | 57 | 23.830 | 33.680 | 47 |
| 0.522 | 9.760 | 0.100 | H | 29.290 | 39.150 | 56 | 27.240 | 37.100 | 46 |
| 0.526 | 9.750 | 0.100 | N | 27.740 | 37.590 | 56 | 25.810 | 35.660 | 46 |
| 0.587 | 9.760 | 0.100 | H | 28.290 | 38.150 | 56 | 25.770 | 35.630 | 46 |
| 1.839 | 9.760 | 0.100 | N | 25.900 | 35.760 | 56 | 24.560 | 34.420 | 46 |
| 2.692 | 9.774 | 0.100 | N | 26.896 | 36.770 | 56 | 25.846 | 35.720 | 46 |
| 3.020 | 9.780 | 0.100 | N | 26.840 | 36.720 | 56 | 25.190 | 35.070 | 46 |
| 5.577 | 9.796 | 0.100 | N | 24.714 | 34.610 | 60 | 22.084 | 31.980 | 50 |
| 5.635 | 9.796 | 0.100 | N | 21.934 | 31.830 | 60 | 4.804 | 14.700 | 50 |
| 5.702 | 9.797 | 0.100 | N | 17.023 | 26.920 | 60 | 4.563 | 14.460 | 50 |
| 5.888 | 9.809 | 0.100 | H | 18.131 | 28.040 | 60 | 4.551 | 14.460 | 50 |
| 14.010 | 9.850 | 0.190 | H | 12.350 | 22.390 | 60 | 9.380 | 19.420 | 50 |
| 22.695 | 9.990 | 0.100 | H | 15.490 | 25.580 | 60 | 12.220 | 22.310 | 50 |

[Hot]



[Neutral]



Appendix A – Test equipment used for test

| Equipment | Manufacturer | Model | Calibration due. |
|--------------------------|-----------------------|---------------|------------------|
| Spectrum Analyzer | R&S | FSV30 | 2012-01-07 |
| Trilog-Broadband Antenna | SCHWARZBECK | VULB 9168 | 2013-03-18 |
| Horn Antenna | A.H. System | SAS-571 | 2013-03-22 |
| High Pass Filter | Wainwright Instrument | WHJS3000-10TT | 2012-01-07 |
| Attenuator | HP | 8491B | 2012-05-04 |
| Preamplifier | A.H. | PAM-0118 | 2012-05-04 |
| EMI Test Receiver | R&S | ESHS10 | 2012-05-09 |
| LISN | R&S | ENV216 | 2012-02-16 |

Peripheral devices

| Device | Manufacturer | Model No. | Serial No. |
|----------|---------------------|-----------|-----------------|
| Notebook | Samsung electronics | R159 | ZKPA93AS900167D |
| Notebook | Fujitsu | A6020 | FPC03209CZ |

Test setup photo and configuration

Radiated field emissions



AC conducted emission

